



BUREAU
VERITAS

Test Report No.: FS170816N062

RF EXPOSURE REPORT

Applicant	Bellabeat.inc
Address	2 Mint Plaza, San Francisco, CA 94103

Manufacturer or Supplier	Bellabeat.inc
Address	2 Mint Plaza, San Francisco, CA 94103
Product	Spring
Brand Name	N/A
Model	Spring
Additional Model & Model Difference	N/A
Date of tests	Aug. 16, 2017 ~ Sep. 06, 2017
☒ FCC Part 2 (Section 2.1091)	
☒ KDB 447498 D01	
☒ IEEE C95.1	

CONCLUSION: The submitted sample was found to COMPLY with the test requirement

Tested by Breeze Jiang Project Engineer / EMC Department	Approved by Glyn He Supervisor / EMC Department
	 Date: Sep. 12, 2017

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RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
FS170816N062	Original release	Sep. 12, 2017

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1. CERTIFICATION

FCC ID:	2AELF-SP01
PRODUCT:	Spring
BRAND NAME:	N/A
MODEL NO.:	Spring
ADDITIONAL NO.:	N/A
TEST SAMPLE:	Engineering Sample
APPLICANT:	Bellabeat.inc
STANDARDS:	FCC Part 2 (Section 2.1091)
	KDB 447498 D01
	IEEE C95.1

2. RF EXPOSURE DEFINE

The corresponding SAR Exclusion Threshold condition, listed below:

- 1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

$$[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}] \leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, where}$$

- $f(\text{GHz})$ is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:
- a) [Threshold at 50 mm in step 1) + (test separation distance - 50 mm) · (f(MHz)/150)] mW, at 100 MHz to 1500 MHz
 - b) [Threshold at 50 mm in step 1) + (test separation distance - 50 mm) · 10] mW at > 1500 MHz and ≤ 6 GHz
- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.
- a) The threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(\text{MHz}))]$ for test separation distances > 50 mm and < 200 mm.
 - b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for test separation distances ≤ 50 mm.
 - c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.

3. CLASSIFICATION

The antenna of this product, under normal use condition, is at less than 20cm away from the body of the user. So, this device is classified as **Portable Device**.



4. SAR TEST EXCLUSION THRESHOLDS

The tuned conducted Average Power (declared by client)

Mode	Frequency (MHz)	Target Power (dBm)	Tolerance (dBm)	Lower Tolerance (dBm)	Upper Tolerance (dBm)
BT-LE	2402-2480	-16	+2	-18	-14

The measured conducted Average Power

Mode	Frequency (MHz)	Averaged Power (dBm)
BT-LE	2480	-15.28

SAR Test Exclusion Thresholds

Mode	Frequency (MHz)	Maximum source-based time averaged conducted output power (dBm)	Minimum separation distance (mm)	Result of Eq. 1	Limit for 1-g SAR	Limit for 10-g extremity SAR	Verdict
BT-LE	2402-2480	-14	5	0.0125	3.0	7.5	Exempt from SAR

Conclusion

Therefore this device complies with FCC's RF radiation exposure limits for general population without SAR evaluation.